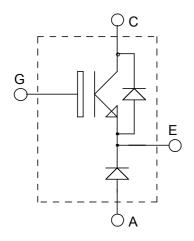


ISOTOP® Buck chopper NPT IGBT

$$V_{CES} = 600V$$

 $I_{C} = 30A$ @ $T_{C} = 100$ °C



Application

- AC and DC motor control
- Switched Mode Power Supplies

- Non Punch Through (NPT) THUNDERBOLT IGBT
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 100 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - RBSOA and SCSOA rated
- ISOTOP® Package (SOT-227)
- Very low stray inductance
- High level of integration



- Outstanding performance at high frequency operation
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive T_C of V_{CEsat}
- **RoHS Compliant**



Absolute maximum ratings

Symbol	Parameter			Max ratings	Unit
V_{CES}	Collector - Emitter Breakdown Voltage			600	V
I_{C1}	L'ontinuous L'ollector L'urrent		$T_C = 25$ °C	58	
I_{C2}			$T_{\rm C} = 100^{\circ}{\rm C}$	30	Α
I_{CM}	Pulsed Collector Current	$T_C = 25^{\circ}C$	110		
V_{GE}	Gate – Emitter Voltage			±20	V
P_{D}	Maximum Power Dissipation		$T_C = 25$ °C	192	W
I_{LM}	RBSOA clamped Inductive load Current R_G =11 Ω		$T_C = 25^{\circ}C$	60	A
IF_{AV}	Maximum Average Forward Current	Duty cycle=0.5	$T_C = 80$ °C	30	A
IF_{RMS}	RMS Forward Current (Square wave, 50% duty)			39	Λ

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.



All ratings @ $T_j = 25^{\circ}C$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I_{CES}	Zero Gate Voltage Collector Current				40	4	
			$T_j = 125$ °C			1000	μΑ
V _{CE(sat)}	Collector Emittor acturation Voltage	$V_{GE} = 15V$	$T_j = 25$ °C		2.0	2.5	V
	Collector Emitter saturation Voltage	$I_C = 30A$	$T_j = 125$ °C		2.2	2.8	v
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_{C} = 700 \mu A$		3	4	5	V
I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = \pm 20V, V_{CE} = 0V$				±100	nA

Dynamic Characteristics

Dynamic Characteristics							
Symbol		Test Conditions	Min	Тур	Max	Unit	
Cies	Input Capacitance	$V_{GE} = 0V$		1600	1850		
C_{oes}	Output Capacitance	$V_{CE} = 25V$		150	220	pF	
C_{res}	Reverse Transfer Capacitance	f=1MHz		90	150		
Q_{g}	Total gate Charge	$V_{GS} = 15V$		140	210		
Q_{ge}	Gate – Emitter Charge	$V_{Bus} = 300V$		10	15	nC	
Q_{gc}	Gate – Collector Charge	$I_C = 30A$		60	90		
$T_{d(on)}$	Turn-on Delay Time	Resistive Switching (25°C)		13	26	ns	
$T_{\rm r}$	Rise Time	$V_{GE} = 15V$		41	80		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 300V$ $I_C = 30A$		147	220		
$T_{\rm f}$	Fall Time	$R_G = 10\Omega$		200	400		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C)		17	30	ns	
$T_{\rm r}$	Rise Time	$V_{GE} = 15V$		28	60		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 400V$ $I_{\text{C}} = 30A$		242	360		
T_{f}	Fall Time	$R_G = 10\Omega$		34	70		
E_{ts}	Total switching Losses	G		1.2	2	mJ	
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C)		15	30		
$T_{\rm r}$	Rise Time	$V_{GE} = 15V$		27	50	ns	
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 400V$ $I_{\text{C}} = 30A$		265	400	113	
T_{f}	Fall Time	$R_G = 10\Omega$		41	80		
Eon	Turn-on Switching Energy			0.5	1		
E_{off}	Turn-off Switching Energy			1	2	mJ	
E_{ts}	Total switching Losses			1.5	3		



Chopper diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{F}	Diode Forward Voltage	$I_F = 30A$			1.6	1.8	
		$I_F = 60A$			1.9		V
		$I_F = 30A$	$T_i = 125$ °C		1.4		
I_{RM}	Maximum Reverse Leakage Current	$V_{R} = 600V$	$T_j = 25$ °C			250	μA
1RM	Wiaximum Reverse Leakage Current	$V_{R} = 600V$	$T_j = 125$ °C			500	μΛ
C_{T}	Junction Capacitance	$V_{R} = 200V$			44		pF
_	Reverse Recovery Time	$I_F=1A, V_R=30V$ di/dt =100A/\(\mu\)s	$T_j = 25$ °C		23		ns
t_{rr}	Reverse Recovery Time		$T_i = 25^{\circ}C$		85		
			$T_{i} = 125^{\circ}C$		160		
I_{RRM}	Maximum Reverse Recovery Current	$V_{R} = 400V$ $T_{c} = 125^{\circ}$	$T_j = 25$ °C		4		Α
1RRM	Waximum Reverse Recovery Current		$T_i = 125$ °C		8		А
0	Reverse Recovery Charge	$di/dt = 200A/\mu s$	$T_j = 25$ °C		130		nC
Q _{rr}			$T_j = 125$ °C		700		IIC
t _{rr}	Reverse Recovery Time	$I_F = 30A$ $V_R = 400V$ $di/dt = 1000A/\mu s$			70		ns
Q _{rr}	Reverse Recovery Charge		$T_j = 125$ °C		1300		nC
I_{RRM}	Maximum Reverse Recovery Current				30		A

Thermal and package characteristics

Symbol	Characteristic		Min	Тур	Max	Unit	
R_{thJC}	Junction to Case Thermal Resistance IGBT Diode	IGBT			0.65	°C/W	
		Diode			1.21		
R_{thJA}	Junction to Ambient (IGBT & Diode)	ction to Ambient (IGBT & Diode)			20		
V_{ISOL}	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz		2500			V	
T_J, T_{STG}	Storage Temperature Range		-55		150	°C	
$T_{ m L}$	Max Lead Temp for Soldering:0.063" from case for 10 sec				300		
Torque	Mounting torque (Mounting = 8-32 or 4mm Machine and terminals = 4mm Machine)				1.5	N.m	
Wt	Package Weight			29.2		g	

3 – 9



Typical IGBT Performance Curve

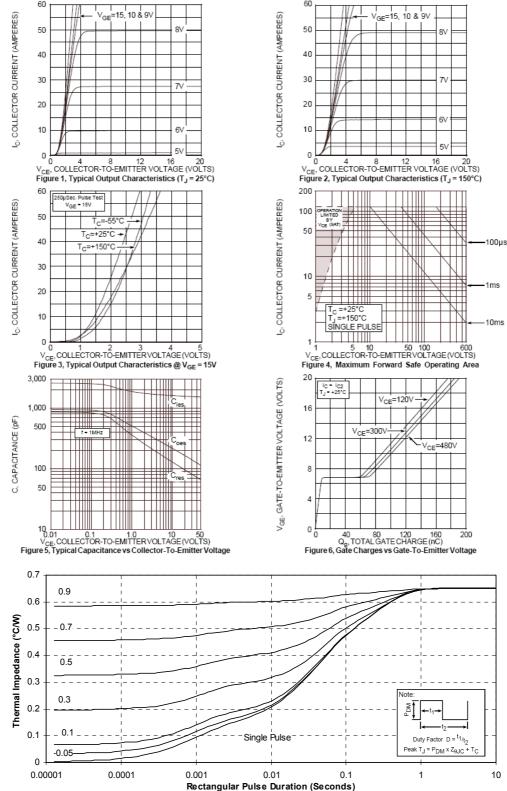
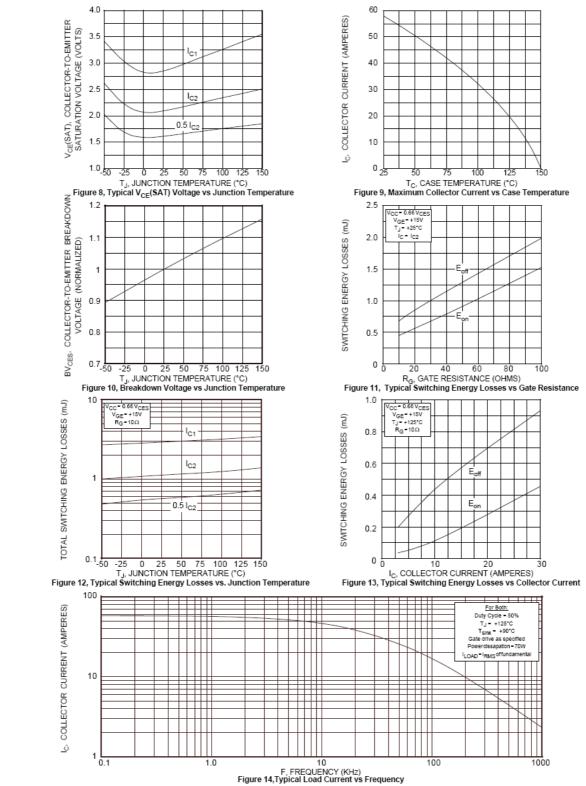


Figure 7, Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration







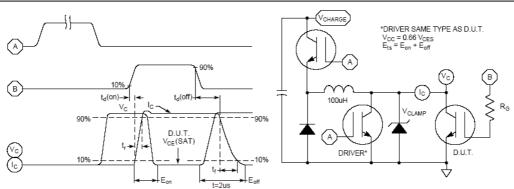


Figure 15, Switching Loss Test Circuit and Waveforms

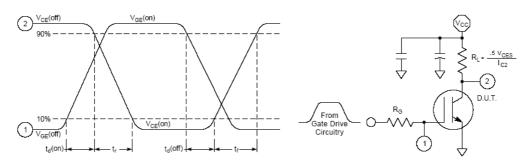
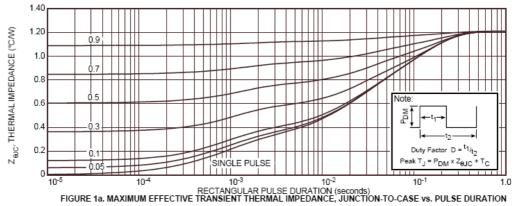


Figure 16, Resistive Switching Time Test Circuit and Waveforms

Typical Diode Performance Curve



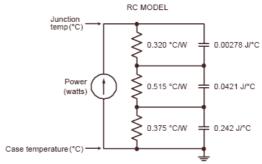


FIGURE 1b, TRANSIENT THERMAL IMPEDANCE MODEL



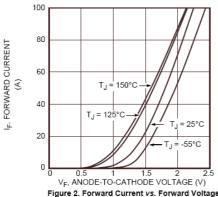


Figure 2. Forward Current vs. Forward Voltage

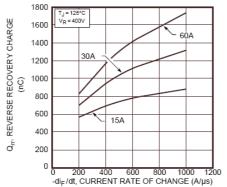


Figure 4. Reverse Recovery Charge vs. Current Rate of Change

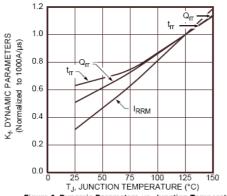


Figure 6. Dynamic Parameters vs. Junction Temperature

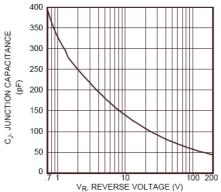


Figure 8. Junction Capacitance vs. Reverse Voltage

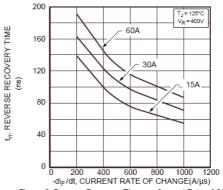


Figure 3. Reverse Recovery Time vs. Current Rate of Change

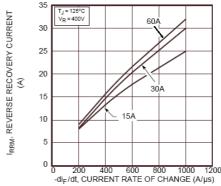


Figure 5. Reverse Recovery Current vs. Current Rate of Change

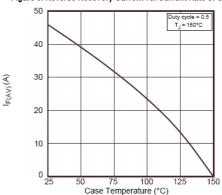


Figure 7. Maximum Average Forward Current vs. CaseTemperature



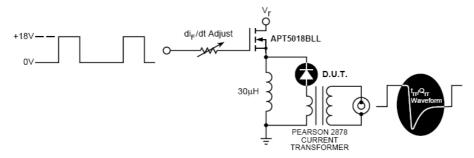
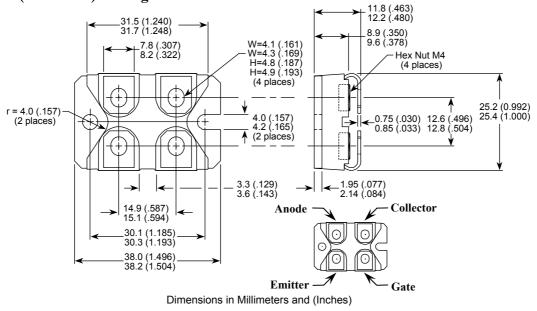


Figure 9. Diode Test Circuit

- 1 I_F Forward Conduction Current
 2 di_F/dt Rate of Diode Current Change Through Zero Crossing.
 3 I_{RRM} Maximum Reverse Recovery Current.
 4 t_{rr} Reverse Recovery Time, measured from zero crossing where diode current goes from positive to negative, to the point at which the straight line through I_{RRM} and 0.25 I_{RRM} passes through zero.
- **5** Q_{rr} Area Under the Curve Defined by I_{RRM} and t_{rr} .

Figure 10, Diode Reverse Recovery Waveform and Definitions

SOT-227 (ISOTOP®) Package Outline



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